A !	Make of through	change ghout.	s to	0 1.3,		DESC				Ed	itor	rial	cha	nge	s		9 AU			4		NOVE I	
A	Make of through	change ghout.	s to	0 1.3,	6.6,	and	i ta	ble	I.	Ed	itor	ial	cha	nge	S	198	9 AU	OG O	3	4	ll.a.		k
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DR.	DARI LITAI AWII	RY NG		CH	PREPARED BY Rich Officer CHECKED BY ROW Monnin APPROVED BY				MICROCIRCUIT, LINEAR, DUAL RS232 TRANSCEIVERS, MONOLITHIC SILICON														
THIS DRAW FOR USE BY AND AG DEPARTM AMSC NA	ALL DI	EPARTM S OF TH	IENTS E	<u> 2</u>	DRÁWING APPROVAL ATT 27 JANUARY 1988 REVISION LEVEL				SIZE A			CODE 268		į	59	62	-87	766	36				

DESC FORM 193 SEP 87

* U.S. GOVERNMENT PRINTING OFFICE: 1987 — 748-129/60911

1. SCOPE			
1.1 <u>Scope</u> . This drawing descr with 1.2.1 of MIL-STD-883, "Provi non-JAN devices".	ribes device requireme isions for the use of	ents for class B micro MIL-STD-883 in conju	ocircuits in accordance action with compliant
1.2 <u>Part number</u> . The complete	e part number shall be	e as shown in the fol	lowing example:
5962-87666	Device type (1.2.1)	Case outline (1.2.2)	X
1.2.1 <u>Device types</u> . The device	e types shall identif	y the circuit function	on as follows:
Device type Ge	eneric number	Circuit fund	ction
01 02	LT1080 LT1081	RS232 transceiver v RS232 transceiver,	vith shutdown, bipolar bipolar
1.2.2 <u>Case outlines</u> . The case as follows:	e outlines shall be as	designated in append	fix C of MIL-M-38510, and
Outline letter		Case outline	2
E V	D-2 (16-lead, . D-6 (18-lead, .	840" x .310" x .200") 960" x .310" x .200")	, dual-in-line package , dual-in-line package
1.3 Absolute maximum ratings.			
Supply voltage (VCC) Positive power supply volta Negative power supply volta Driver input voltage Receiver input voltage On-off input voltage (pin 1 Driver output voltage - Receiver output voltage - Short circuit duration, (V'Short circuit duration, (V'Short circuit duration, dri Power dissipation (PD) Thermal resistance, junction Thermal resistance, junction Case E Case V Maximum junction temperatur Storage temperature (soldering	Rege (Y ⁺)		to V ⁺ -30 V dc to V _{CC} +0.3 V dc 2/ 38510, appendix C
1/ Must withstand the added P _D d Z/ Derate at 9.5 mW/°C above T _A	ue to short circuit t = +70°C	est; e.g., I _{OS} .	

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1.4 Recommended operating conditions.

Supply voltage (VCC) - - - - - - - - - - - - - +4.5 V dc to +5.5 V dc Ambient operating temperature range (T_A) - - - - - - - - - - - - - - - 55 °C to +125 °C

2. APPLICABLE DOCUMENTS

2.1 Government specification, standard, and bulletin. Unless otherwise specified, the following specification, standard, and bulletin of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510

- Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883

- Test Methods and Procedures for Microelectronics.

BULLETIN

MILITARY

MIL-BUL-103

- List of Standardized Military Drawings (SMD's).

(Copies of the specification, standard, and bulletin required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

- 2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.
 - 3. REQUIREMENTS
- 3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.
- 3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
 - 3.2.1 Terminal connections. The terminal connections shall be as specified on figure 1.
 - 3.2.2 Case outlines. The case outlines shall be in accordance with 1.2.2 herein.
- 3.3 Electrical performance characteristics. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and apply over the full ambient operating temperature range.
- 3.4 Electrical test requirements. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are described in table I.
- 3.5 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in MIL-BUL-103 (see 6.6 herein).

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TABLE I. Electrical performance characteristics. Test |Symbol Conditions |Device| Group A Limits Unit -55°C < T_A < +125°C +4.5 V dC < V_{CC} < +5.5 V dc V_{ON-OFF} = 3.0 V dc unless otherwise specified type |subgroups Min Max | Positive | TR1, TR2 each loaded | with 3 kΩ to GND Output voltage swing I VOUT A11 1, 2, 3 | 5.0 ٧ |Negative Low level input voltage IVIL $|V_{OUT}| = high$ A11 1, 2, 3 0.81 High level input voltage IVIH All IVOUT = low 11, 2, 3 | 2.01 Logic input current high |IIH |V_{IN} > 2.0 V A11 1, 2, 3 1200 μА Logic input current low IIL | VIN < 0.8 V A11 1, 2, 3 200 Output short circuit sourcing current sinking current IOST 140UT = 0 A A11 1 mΑ current (transmitter) $|V_{OUT} = \pm 30 \text{ V dc}$ Output leakage current 01 LOZT 1, 2, 3 1100 μА (transmitter) 1/ $R_L = 3 k\Omega$, $C_L = 51 pF$ $T_A = +25 C$ Slew rate V/µs S.R. A11 4 30 RS-232 input threshold ٧ VTL $V_{OUT} = high$ A11 1, 2, 3 0.2 RS-232 input threshold V_{TH} A11 | V_{OUT} = low 1, 2, 3 3.01 high RS-232 input hysteresis I۷H All 1, 2, 3 0.1 1.0 Receiver input resistance | RI A11 1 3.01 7.01 kΩ Receiver output high IOUT = 160 µA; VCC = 5 V I V_{OH} A11 1, 2, 3 ٧ 3.5 voltage Receiver output low VOL $I_{OUT} = -1.6 \text{ mA}$ A11 1, 2, 3 0.41 voltage

See footnotes at end of table.

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TABLE	I. Elec	ctrical performance characteristi	<u>cs</u> – Cor	tinued.			
Test	Symbol	Conditions -55°C < TA < +125°C +4.5 V dC < VCC < +5.5 V dc VON-OFF = 3.0 V dc	Device type	Group A subgroups	Lim	Unit	
		V _{ON-OFF} = 3.0 V dc unless otherwise specified	 		Min	Max	
Output short circuit current (receiver)	IOSR	Y _{OUT} = Y _{CC} , sinking current	A11	1	-10	<u> </u>	l lmA l
	 	V _{OUT} = 0 V dc, sourcing current	 	 	 0.6 		
Output leakage current (receiver) 1/	IOZR	IO V < VOUT < VCC	01	1, 2, 3		10	μ A
Supply current	Icc	 Outputs unloaded 	All	1, 2, 3		22	mA.
V+ output voltage <u>2</u> /	V ₀₊	I _{OUT} = 0 mA	All	1	8.0		V
		I _{OUT} = 10 mA] 		7.0		
		I _{OUT} = 15 mA			6.5		
V- output voltage 2/	V ₀₋	I OUT = 0 mA	A11	1	-7.5		
	 	 I _{OUT} = -10 mA] 	 	-5.5]
	 	I _{OUT} = -15 mA	[] [] []		-5.0		
Supply leakage current 1/2/	Iccz	 Shutdown mode 	01	1		100	μ Α
ON-OFF pin current	ISHUT	0 V <u><</u> V _{ON-OFF} <u><</u> 5 V	01	1	-15	80	

^{1/} $V_{ON-OFF} = 0.4 \text{ V for } -55^{\circ}\text{C} \leq T_A \leq +100^{\circ}\text{C}$, and $V_{ON-OFF} = 0.2 \text{ V for } +100^{\circ}\text{C} \leq T_A \leq +125^{\circ}\text{C}$.

^{3.6} Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in MIL-BUL-103 (see 6.6 herein). The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall affirm that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.

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 V_{CC} = 5 V, external loading of V+ and V- equals zero, and the driver outputs are low (inputs high).

- 3.7 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.
- 3.8 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).
- 3.9 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.
 - 4. QUALITY ASSURANCE PROVISIONS
- 4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 <u>Screening.</u> Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
 - a. Burn-in test, method 1015 of MIL-STD-883:
 - Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.
- 4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.
 - 4.3.1 Group A inspection.
 - a. Tests shall be as specified in table II herein.
 - b. Subgroups 5, 6, 7, 8, 9, 10, and 11 in table I, method 5005 of MIL-STD-883 shall be omitted.
 - 4.3.2 Groups C and D inspections.
 - a. End-point electrical parameters shall be as specified in table II herein.
 - b. Steady-state life test conditions, method 1005 of MIL-STD-883:
 - Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

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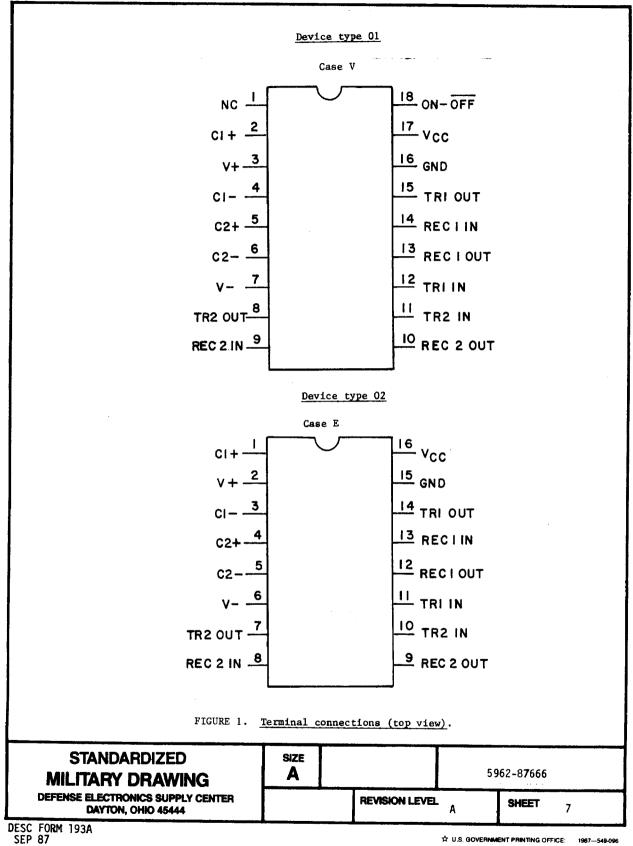


TABLE II. Electrical test requirements.

 MIL-STD-883 test requirements 	Subgroups (per method 5005, table I)
 Interim electrical parameters (method 5004)	1
 Final electrical test parameters (method 5004)	1*, 2, 3, 4
Group A test requirements (method 5005)	1, 2, 3, 4
Groups C and D end-point electrical parameters (method 5005)	1, 2, 3

^{*} PDA applies to subgroup 1.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

- 6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.
- 6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
- 6.3 Configuration control of SMD's. All proposed changes to existing SMD's will be coordinated with the users of record for the individual documents. This coordination will be accomplished in accordance with MIL-STD-481 using DD Form 1693, Engineering Changes Proposal (Short Form).
- 6.4 Record of users. Military and industrial users shall inform Defense Electronics Supply Center when a system application requires configuration control and the applicable SMD. DESC will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronics devices (FSC 5962) should contact DESC-ECS, telephone (513) 296-6022.
- 6.5 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.

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DAYTON, OHIO 45444

 6.6 Approved sources of supply. Approved sources of supply are listed in MIL-BUL-103. Additional sources will be added to MIL-BUL-103 as they become available. The vendors listed in MIL-BUL-103 have agreed to this drawing and a certificate of compliance (see 3.6 herein) has been submitted to and accepted by DESC-ECS. The approved source of supply listed below is for information purposes only and is current only to the date of the last action of this document.

Military drawing part number 	Vendor CAGE number	Vendor similar part number 1/
5962-8766601VX	64155	 LT1080MJ/883
5962-8766602EX	64155	LT1081MJ/883

1/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE number

64155

Vendor name and address

Linear Technology Corporation 1630 McCarthy Boulevard Milpitas, CA 95035-7487

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